

# FEATURES

Designed and guaranteed for 210°C operation Low noise 1 nV/√Hz input noise 45 nV/√Hz output noise **High CMRR** 126 dB CMRR (minimum), G = 100 80 dB CMRR (minimum) to 5 kHz, G = 1 **Excellent ac specifications** 15 MHz bandwidth (G = 1) 1.2 MHz bandwidth (G = 100) 22 V/µs slew rate THD: -130 dBc (1 kHz, G = 1) Versatile ±4 V to ±17 V dual supply Gain set with single resistor (G = 1 to 1000) Specified temperature range -40°C to +210°C, SBDIP package -40°C to +175°C, SOIC package

#### **APPLICATIONS**

Down-hole instrumentation Harsh environment data acquisition Exhaust gas measurements Vibration analysis

# **GENERAL DESCRIPTION**

The AD8229 is an ultralow noise instrumentation amplifier designed for measuring small signals in the presence of large common-mode voltages and high temperatures.

The AD8229 has been designed for high temperature operation. The process is dielectrically isolated to avoid leakage currents at high temperatures. The design architecture was chosen to compensate for the low  $V_{BE}$  voltages at high temperatures.

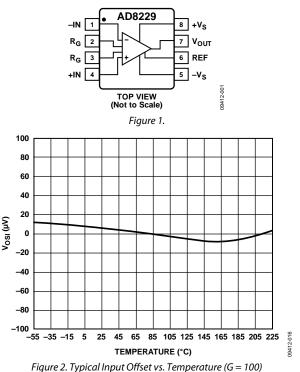
The AD8229 excels at measuring tiny signals. It delivers industry leading 1 nV/ $\sqrt{\text{Hz}}$  input noise performance. The high CMRR of the AD8229 prevents unwanted signals from corrupting the acquisition. The CMRR increases as the gain increases, offering high rejection when it is most needed.

The AD8229 is one of the fastest instrumentation amplifiers available. Its current feedback architecture provides high

# $1 \text{ nV}/\sqrt{\text{Hz}}$ Low Noise 210°C Instrumentation Amplifier

# AD8229

# FUNCTIONAL BLOCK DIAGRAM



bandwidth at high gain, for example, 1.2 MHz at G = 100. The design includes circuitry to improve settling time after large input voltage transients. The AD8229 was designed for excellent distortion performance, allowing use in demanding applications such as vibration analysis.

Gain is set from 1 to 1000 with a single resistor. A reference pin allows the user to offset the output voltage. This feature can be useful when interfacing with analog-to-digital converters.

For the most demanding applications, the AD8229 is available in an 8-lead side-brazed ceramic dual in-line package (SBDIP). For space-constrained applications, the AD8229 is available in an 8-lead plastic standard small outline package (SOIC).

Rev. B

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# **REVISION HISTORY**

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Added Predicted Lifetime vs. Operating Temperature Section an	nd
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# **SPECIFICATIONS**

+Vs = 15 V, -Vs = -15 V, V\_{REF} = 0 V,  $T_{A}$  = 25°C, G = 1, RL = 10 k $\Omega$ , unless otherwise noted.

#### Table 1.

Parameter	<b>Test Conditions/Comments</b>	Min	Тур	Max	Unit
COMMON-MODE REJECTION RATIO (CMRR)					
CMRR DC to 60 Hz with 1 k $\Omega$ Source Imbalance	$V_{CM} = \pm 10 \text{ V}$				
G = 1		86			dB
Temperature Drift	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$			300	nV/V/°C
G = 10		106			dB
Temperature Drift	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$			30	nV/V/°C
G = 100		126			dB
Temperature Drift	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$			3	nV/V/°C
G = 1000	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$	134			dB
CMRR at 5 kHz	$V_{CM} = \pm 10 V$				
G = 1		80			dB
G = 10		90			dB
G = 100		90			dB
G = 1000		90			dB
VOLTAGE NOISE	$V_{IN}+$ , $V_{IN}-=0$ V				
Spectral Density <sup>1</sup> : 1 kHz					
Input Voltage Noise, eni			1	1.1	nV/√Hz
Output Voltage Noise, eno			45	50	nV/√Hz
Peak to Peak: 0.1 Hz to 10 Hz					
G = 1			2		μV p-p
G = 1000			100		nV p-p
CURRENT NOISE					
Spectral Density: 1 kHz			1.5		pA/√Hz
Peak to Peak: 0.1 Hz to 10 Hz			100		рАр-р
VOLTAGE OFFSET	$V_{OS} = V_{OSI} + V_{OSO}/G$				
Input Offset, Vosi				100	μV
Average TC	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$		0.1	1	μV/°C
Output Offset, Voso				1000	μV
Average TC	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$		3	10	μV/°C
Offset RTI vs. Supply (PSR)	$V_s = \pm 5 V \text{ to } \pm 15 V$				
G = 1	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$	86			dB
G = 10	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$	106			dB
G = 100	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$	126			dB
G = 1000	$T_A = -40^{\circ}C \text{ to } +210^{\circ}C$	130			dB
INPUT CURRENT					
Input Bias Current				70	nA
High Temperature	$T_A = 210^{\circ}C$			200	nA
Input Offset Current				35	nA
High Temperature	T <sub>A</sub> = 210°C			50	nA

Test Conditions/Comments	Min	Тур	Мах	Unit
		15		MHz
		4		MHz
		1.2		MHz
		0.15		MHz
10 V step				
		0.75		μs
		0.65		μs
		0.85		μs
		5		μs
10 V step				
		0.9		μs
		0.9		μs
		1.2		μs
		7		μs
		22		V/µs
$f = 1 \text{ kHz}, R_L = 2 \text{ k}\Omega, V_{OUT} = 10 \text{ V p-p}$				
		-130		dBc
		-116		dBc
				dBc
				dBc
$f = 1 \text{ kHz } B_1 = 2 \text{ kO } V_{\text{out}} = 10 \text{ V } \text{ p-p } G = 100$				%
		0.0005		70
$G = 1 + (0 \times 2/1G)$	1		1000	V/V
$V_{out} = \pm 10 V$			1000	• / •
		0.01	0.03	%
				%
				%
				%
$V_{out} = -10 V t_0 \pm 10 V$		0.1	0.5	70
		2		ppm
		Z		ppm
$T_{1} = -40^{\circ}C t_{0} + 210^{\circ}C$		С	5	ppm/°0
		Z		ppm/°C
			-100	
		1 5/12		GΩ∥pF
$V_{\rm r} = \pm 5 V_{\rm r}$ to $\pm 18 V_{\rm r}$ for dual supplies	V 20	cllc.1	11/2 25	V
				V
$T_A = -40 C t0 + 210 C$	-V <sub>S</sub> +2.0		+Vs - 2.3	v
	V- 1 0		ιV- 1Γ	V
T = 210°C				V
				V
$I_A = 1/5^{-1}C$				V
				V
T 210°C				
T <sub>A</sub> = 210°C T <sub>A</sub> = 175°C	$-V_{s} + 1.1$ $-V_{s} + 1.2$		+Vs – 1.1 +Vs – 1.1	V V
	10 V step	$10 \text{ V step}$ $10 \text{ V step}$ $10 \text{ V step}$ $10 \text{ V step}$ $f = 1 \text{ kHz}, \text{ RL} = 2 \text{ k}\Omega, \text{ Vout} = 10 \text{ V p-p}$ $f = 1 \text{ kHz}, \text{ RL} = 2 \text{ k}\Omega, \text{ Vout} = 10 \text{ V p-p}, \text{ G} = 100$ $f = 1 \text{ kHz}, \text{ RL} = 2 \text{ k}\Omega, \text{ Vout} = 10 \text{ V p-p}, \text{ G} = 100$ $G = 1 + (6 \text{ k}\Omega/\text{R}_G)$ $V_{\text{OUT}} = -10 \text{ V to} + 10 \text{ V}$ $1$ $V_{\text{OUT}} = -10 \text{ V to} + 10 \text{ V}$ $1$ $V_{\text{OUT}} = -10 \text{ V to} + 10 \text{ V}$ $1$ $V_{\text{OUT}} = -40^{\circ}\text{C to} + 210^{\circ}\text{C}$ $1 \text{ V}_{\text{T}_{\text{A}}} = -40^{\circ}\text{C to} + 210^{\circ}\text{C}$ $V_{\text{S}} = \pm 5 \text{ V to} \pm 18 \text{ V for dual supplies}$ $-\text{V}_{\text{S}} + 2.8$ $V_{\text{A}} = -40^{\circ}\text{C to} + 210^{\circ}\text{C}$ $-\text{V}_{\text{S}} + 1.9$ $V_{\text{A}} = -40^{\circ}\text{C to} + 210^{\circ}\text{C}$ $-\text{V}_{\text{S}} + 1.9$ $T_{\text{A}} = -40^{\circ}\text{C to} + 210^{\circ}\text{C}$ $-\text{V}_{\text{S}} + 1.9$ $T_{\text{A}} = 210^{\circ}\text{C}$ $-\text{V}_{\text{S}} + 1.1$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$

# AD8229

Parameter	Test Conditions/Comments	Min	Тур	Max	Unit
REFERENCE INPUT					
R <sub>IN</sub>			10		kΩ
lin	$V_{IN}+$ , $V_{IN}-=0$ V		70		μA
Voltage Range		-Vs		+Vs	V
Reference Gain to Output			1		V/V
Reference Gain Error			0.01		%
POWER SUPPLY					
Operating Range		±4		±17	V
Quiescent Current			6.7	7	mA
High Temperature, SBDIP package	$T_A = 210^{\circ}C$			12	mA
High Temperature, SOIC package	T <sub>A</sub> = 175°C			11	mA
TEMPERATURE RANGE					
For Specified Performance⁵					
SBDIP package		-40		+210	°C
SOIC package		-40		+175	°C

<sup>1</sup> Total Voltage Noise =  $\sqrt{(e_{ni}^2 + (e_{no}/G)^2) + e_{RG}^2)}$ . See the Theory of Operation section for more information. <sup>2</sup> These specifications do not include the tolerance of the external gain setting resistor, R<sub>G</sub>. For G>1, R<sub>G</sub> errors should be added to the specifications given in this table.

<sup>3</sup> Differential and common-mode input impedance can be calculated from the pin impedance:  $Z_{DIFF} = 2(Z_{PIN})$ ;  $Z_{CM} = Z_{PIN}/2$ . <sup>4</sup> Input voltage range of the AD8229 input stage only. The input range can depend on the common-mode voltage, differential voltage, gain, and reference voltage. See the input Voltage Range section for more details. <sup>5</sup> For the guaranteed operation time at the maximum specified temperature, refer to the Predicted Lifetime vs. Operating Temperature section.

# **ABSOLUTE MAXIMUM RATINGS**

#### Table 2.

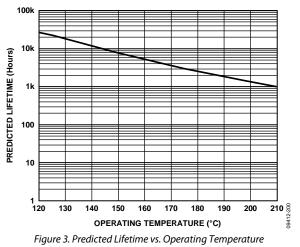
Table 2.	
Parameter	Rating
Supply Voltage	±17 V
Output Short-Circuit Current Duration	Indefinite
Maximum Voltage at –IN, +IN <sup>1</sup>	±Vs
Differential Input Voltage <sup>1</sup>	
Gain ≤ 4	±Vs
4 > Gain > 50	±50 V/gain
Gain ≥ 50	±1 V
Maximum Voltage at REF	±Vs
Storage Temperature Range	–65°C to +150°C
Specified Temperature Range	
SBDIP	-40°C to +210°C
SOIC	-40°C to +175°C
Maximum Junction Temperature	
SBDIP	245°C
SOIC	200°C
ESD	
Human Body Model	4 kV
Charge Device Model	1.5 kV
Machine Model	200 V

<sup>1</sup>For voltages beyond these limits, use input protection resistors. See the Theory of Operation section for more information.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# PREDICTED LIFETIME VS. OPERATING TEMPERATURE

Comprehensive reliability testing is performed on the AD8229. Product lifetimes at extended operating temperature are obtained using high temperature operating life (HTOL). Lifetimes are predicted from the Arrhenius equation, taking into account potential design and manufacturing failure mechanism assumptions. HTOL is performed to JEDEC JESD22-A108. A minimum of three wafer fab and assembly lots are processed through HTOL at the maximum operating temperature. Comprehensive reliability testing is performed on all Analog Devices, Inc., high temperature (HT) products.



Refer to the AD8229 Predicted Lifetime vs. Operating Temperature document for the most up-to-date reliability data.

# THERMAL RESISTANCE

 $\theta_{JA}$  is specified for a device in free air using a 4-layer JEDEC printed circuit board (PCB).

#### Table 3.

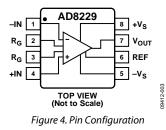
Package Type	Αιθ	Unit
8-Lead SBDIP	100	°C/W
8-Lead SOIC	121	°C/W

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

# PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

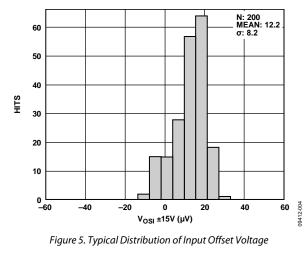


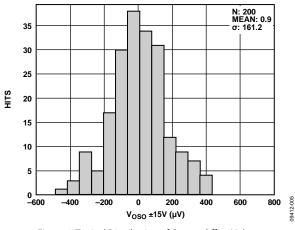
#### **Table 4. Pin Function Descriptions**

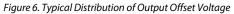
Pin No.	Mnemonic	Description
1	-IN	Negative Input Terminal.
2, 3	R <sub>G</sub>	Gain Setting Terminals. Place resistor across the $R_G$ pins to set the gain. $G = 1 + (6 \text{ k}\Omega/R_G)$ .
4	+IN	Positive Input Terminal.
5	-Vs	Negative Power Supply Terminal.
6	REF	Reference Voltage Terminal. Drive this terminal with a low impedance voltage source to level-shift the output.
7	Vout	Output Terminal.
8	+Vs	Positive Power Supply Terminal.

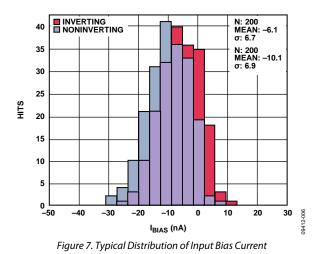
# **TYPICAL PERFORMANCE CHARACTERISTICS**

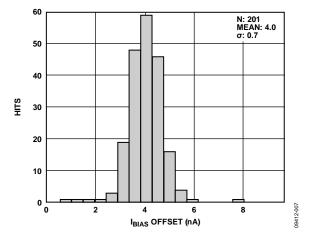
T = 25°C,  $V_{\text{S}}$  = ±15,  $V_{\text{REF}}$  = 0,  $R_{\text{L}}$  = 2 k $\Omega$ , unless otherwise noted.

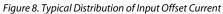


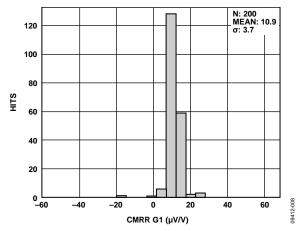


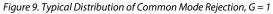


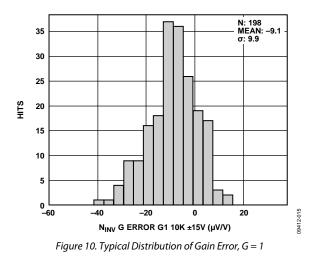


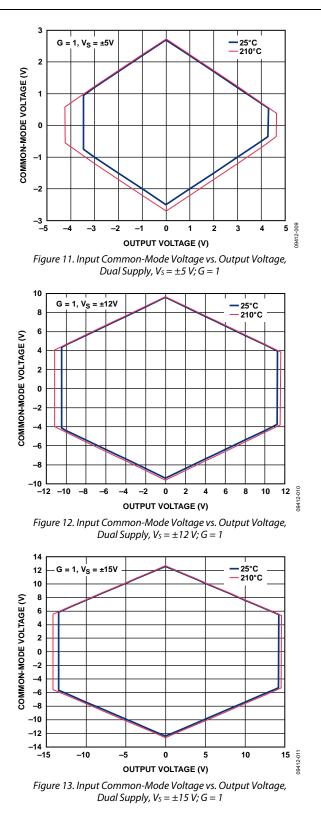


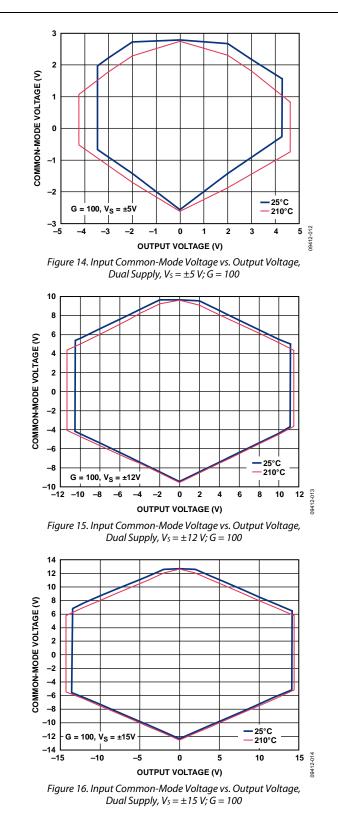










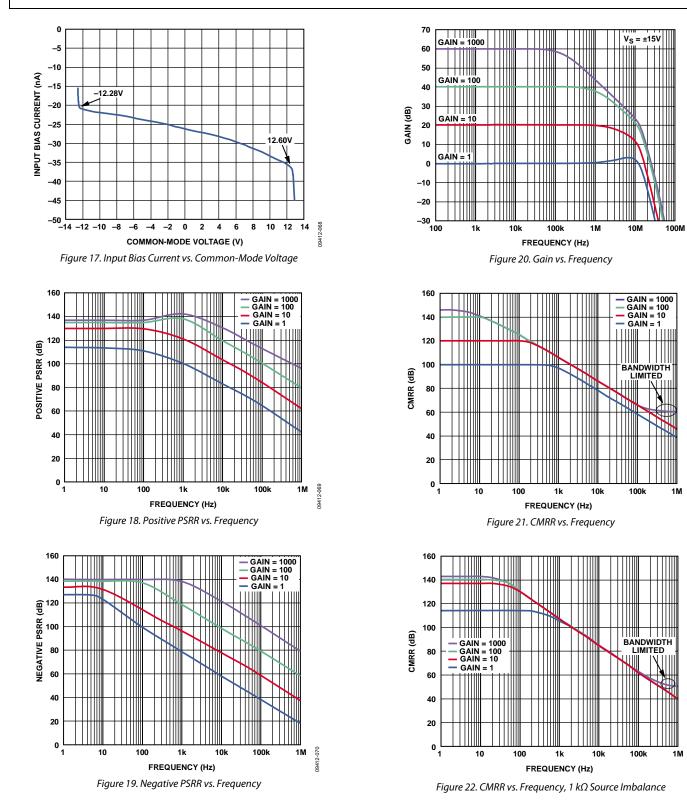


**Data Sheet** 

09412-017

09412-018

09412-019



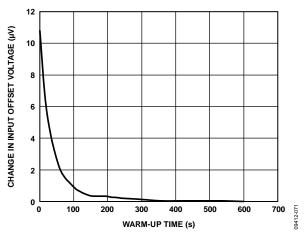
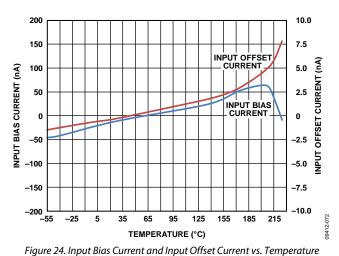


Figure 23. Change in Input Offset Voltage (Vosi) vs. Warm-Up Time





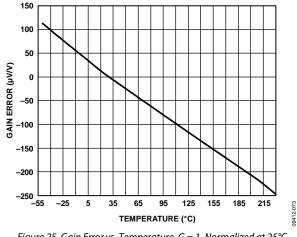
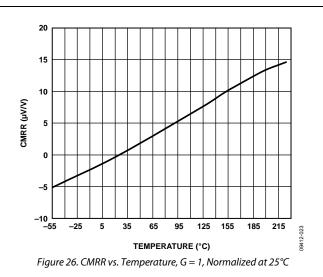
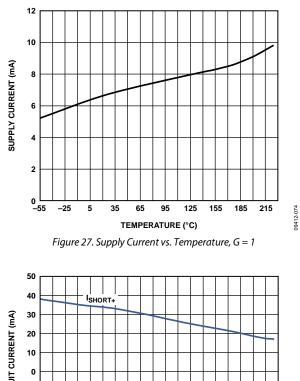
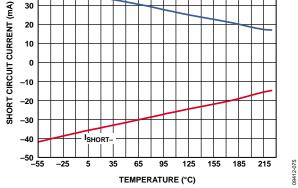
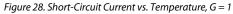


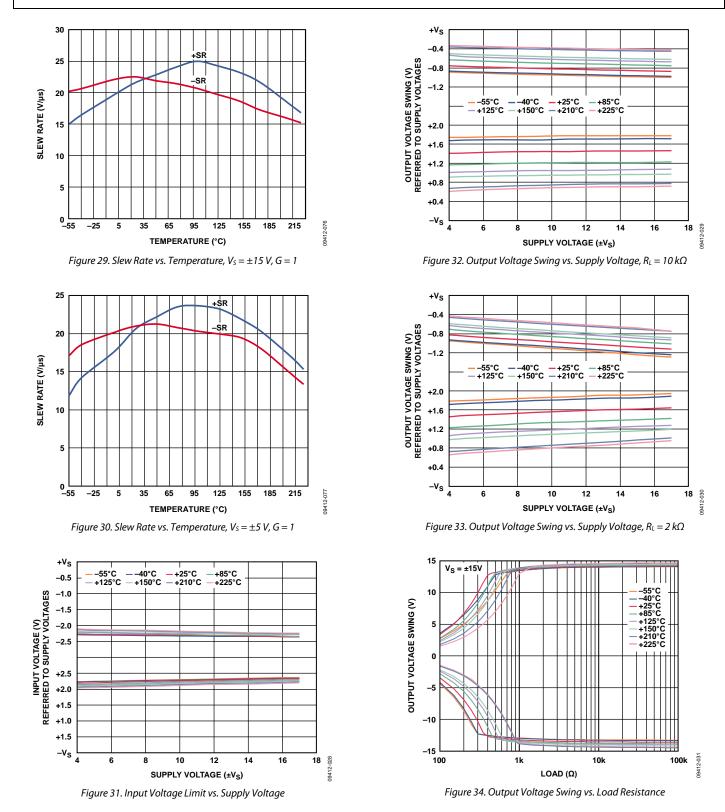
Figure 25. Gain Error vs. Temperature, G = 1, Normalized at 25°C



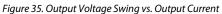


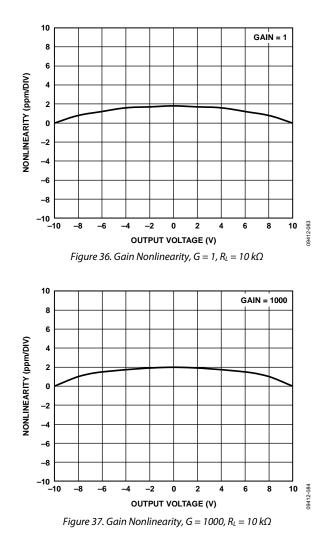


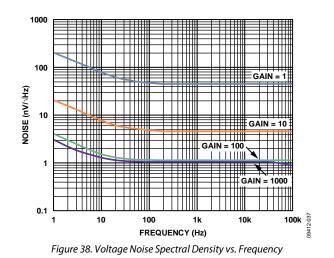




#### +Vs $V_S = \pm 15V$ -0.4 OUTPUT VOLTAGE SWING (V) REFERRED TO SUPPLY VOLTAGES -0.8 -1.2 ++++-1.6 +++ -+25°C -+210°C –55°C -40°C +85°C +125°C -+150°C +225°C $\left| \right| \left| \right|$ +++ +1.8 +1.6 +1.2 +0.8 +0.4 –V<sub>S</sub> ∟ 10µ 100µ 1m 5m 09412-032 **OUTPUT CURRENT (A)**

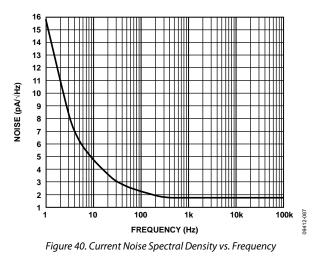






GAIN = 1000, 100nV/DIV GAIN = 1, 2μV/DIV GAIN = 1, 2μV/DIV 15/DIV

Figure 39. 0.1 Hz to 10 Hz RTI Voltage Noise, G = 1, G = 1000



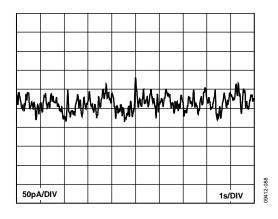
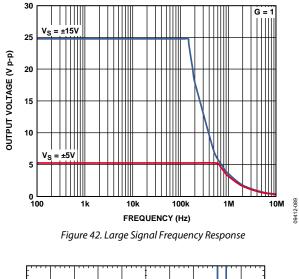


Figure 41. 1 Hz to 10 Hz Current Noise



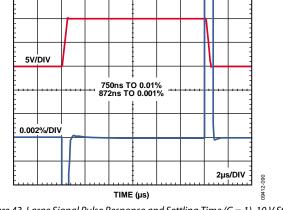


Figure 43. Large Signal Pulse Response and Settling Time (G = 1), 10 V Step,  $V_{\rm S}$  =  $\pm 15$  V

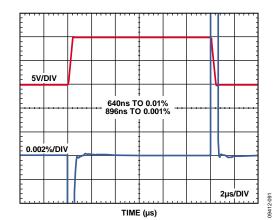


Figure 44. Large Signal Pulse Response and Settling Time (G = 10), 10 V Step,  $V_{\rm S} = \pm 15$  V

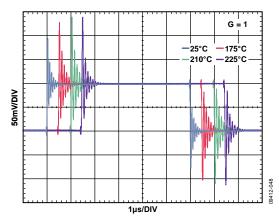
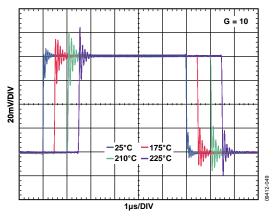
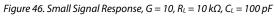


Figure 45. Small Signal Response, G = 1,  $R_L = 10 k\Omega$ ,  $C_L = 100 pF$ 





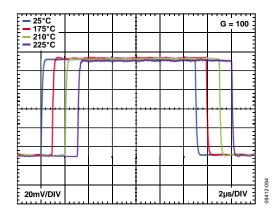


Figure 47. Small Signal Response, G = 100,  $R_L = 10 \text{ k}\Omega$ ,  $C_L = 100 \text{ pF}$ 

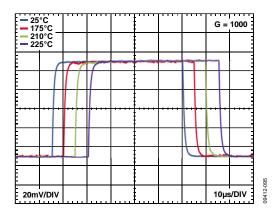


Figure 48. Small Signal Response, G = 1000,  $R_L = 10 k\Omega$ ,  $C_L = 100 pF$ 

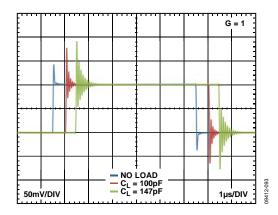
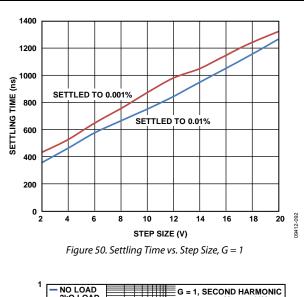
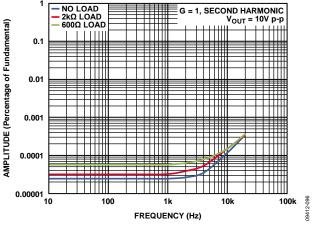
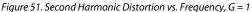


Figure 49. Small Signal Response with Various Capacitive Loads, G = 1,  $R_{L} = Infinity$ 







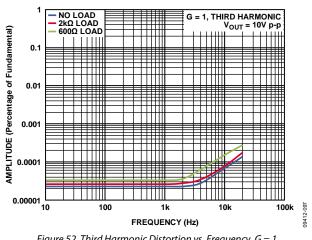


Figure 52. Third Harmonic Distortion vs. Frequency, G = 1

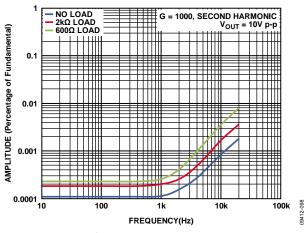


Figure 53. Second Harmonic Distortion vs. Frequency, G = 1000

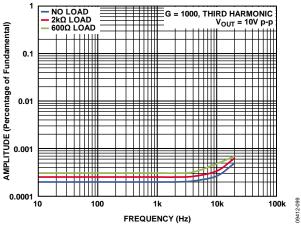
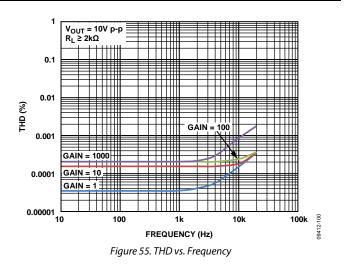
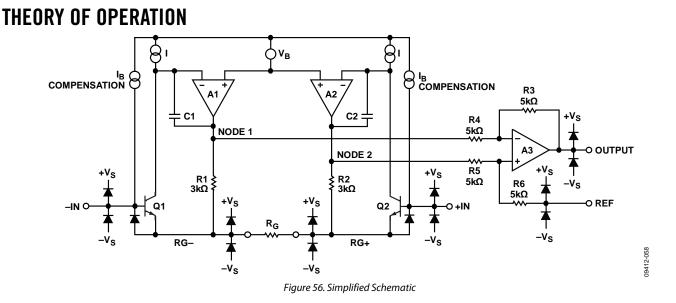


Figure 54. Third Harmonic Distortion vs. Frequency, G = 1000





# ARCHITECTURE

The AD8229 is based on the classic 3-op-amp topology. This topology has two stages: a preamplifier to provide differential amplification followed by a difference amplifier that removes the common-mode voltage and provides additional amplification. Figure 56 shows a simplified schematic of the AD8229.

The first stage works as follows. To keep its two inputs matched, Amplifier A1 must keep the collector of Q1 at a constant voltage. It does this by forcing RG– to be a precise diode drop from –IN. Similarly, A2 forces RG+ to be a constant diode drop from +IN. Therefore, a replica of the differential input voltage is placed across the gain setting resistor, R<sub>G</sub>. The current that flows through this resistance must also flow through the R1 and R2 resistors, creating a gained differential signal between the A2 and A1 outputs.

The second stage is a G = 1 difference amplifier, composed of Amplifier A3 and the R3 through R6 resistors. This stage removes the common-mode signal from the amplified differential signal.

The transfer function of the AD8229 is

 $V_{OUT} = G \times (V_{IN+} - V_{IN-}) + V_{REF}$ 

where:

$$G = 1 + \frac{6 \text{ k}\Omega}{R_G}$$

#### GAIN SELECTION

Placing a resistor across the R<sub>G</sub> terminals sets the gain of the AD8229, which can be calculated by referring to Table 5 or by using the following gain equation:

$$R_G = \frac{6 \,\mathrm{k}\Omega}{G - 1}$$

Table 5. Gains Achi	eved Using 1% Resistors
---------------------	-------------------------

Tuble 5. Guills Heilieven Collig 170 K	
1% Standard Table Value of $R_G(\Omega)$	Calculated Gain
6.04 k	1.993
1.5 k	5.000
665	10.02
316	19.99
121	50.59
60.4	100.34
30.1	200.34
12.1	496.9
6.04	994.4
3.01	1994.355

The AD8229 defaults to G = 1 when no gain resistor is used. The tolerance and gain drift of the  $R_G$  resistor should be added to the AD8229's specifications to determine the total gain accuracy of the system. When the gain resistor is not used, gain error and gain drift are minimal.

#### **R**<sub>G</sub> Power Dissipation

The AD8229 duplicates the differential voltage across its inputs onto the  $R_G$  resistor. The  $R_G$  resistor size should be chosen to handle the expected power dissipation.

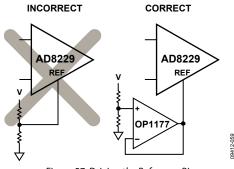
# **REFERENCE TERMINAL**

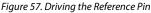
The output voltage of the AD8229 is developed with respect to the potential on the reference terminal. This is useful when the output signal must be offset to a precise midsupply level. For example, a voltage source can be tied to the REF pin to levelshift the output so that the AD8229 can drive a single-supply ADC. The REF pin is protected with ESD diodes and should not exceed either  $+V_S$  or  $-V_S$  by more than 0.3 V.

For best performance, source impedance to the REF terminal should be kept well below 1  $\Omega$ . As shown in Figure 56, the reference terminal, REF, is at one end of a 5 k $\Omega$  resistor. Additional impedance at the REF terminal adds to this 5 k $\Omega$  resistor and results in amplification of the signal connected to the positive input. The amplification from the additional R<sub>REF</sub> can be calculated as follows:

 $2(5 \text{ k}\Omega + R_{REF})/(10 \text{ k}\Omega + R_{REF})$ 

Only the positive signal path is amplified; the negative path is unaffected. This uneven amplification degrades CMRR.



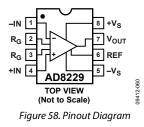


#### **INPUT VOLTAGE RANGE**

Figure 11 through Figure 16 show the allowable common-mode input voltage ranges for various output voltages and supply voltages. The 3-op-amp architecture of the AD8229 applies gain in the first stage before removing common-mode voltage with the difference amplifier stage. Internal nodes between the first and second stages (Node 1 and Node 2 in Figure 56) experience a combination of a gained signal, a common-mode signal, and a diode drop. This combined signal can be limited by the voltage supplies even when the individual input and output signals are not limited.

# LAYOUT

To ensure optimum performance of the AD8229 at the PCB level, care must be taken in the design of the board layout. The pins of the AD8229 are arranged in a logical manner to aid in this task.



#### Common-Mode Rejection Ratio over Frequency

Poor layout can cause some of the common-mode signals to be converted to differential signals before reaching the in-amp. Such conversions occur when one input path has a frequency response that is different from the other. To keep CMRR over frequency high, the input source impedance and capacitance of each path should be closely matched. Additional source resistance in the input path (for example, for input protection) should be placed close to the in-amp inputs, which minimizes their interaction with parasitic capacitance from the PCB traces.

Parasitic capacitance at the gain setting pins can also affect CMRR over frequency. If the board design has a component at the gain setting pins (for example, a switch or jumper), the component should be chosen so that the parasitic capacitance is as small as possible.

#### **Power Supplies**

A stable dc voltage should be used to power the instrumentation amplifier. Noise on the supply pins can adversely affect performance. See the PSRR performance curves in Figure 18 and Figure 19 for more information.

A 0.1  $\mu F$  capacitor should be placed as close as possible to each supply pin. As shown in Figure 59, a 10  $\mu F$  tantalum capacitor can be used farther away from the part. In most cases, it can be shared by other precision integrated circuits.

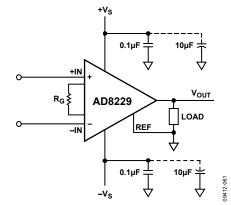


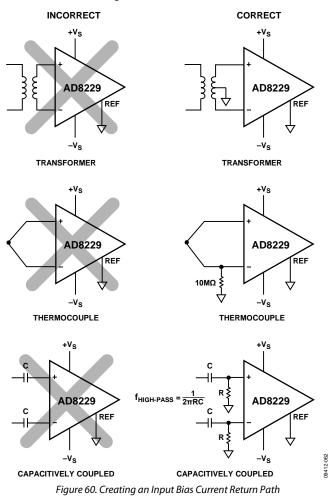
Figure 59. Supply Decoupling, REF, and Output Referred to Local Ground

#### **Reference** Pin

The output voltage of the AD8229 is developed with respect to the potential on the reference terminal. Care should be taken to tie REF to the appropriate local ground.

# **INPUT BIAS CURRENT RETURN PATH**

The input bias current of the AD8229 must have a return path to ground. When using a floating source without a current return path, such as a thermocouple, a current return path should be created, as shown in Figure 60.



# **INPUT PROTECTION**

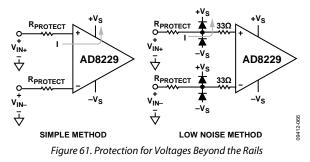
The inputs to the AD8229 should be kept within the ratings stated in the Absolute Maximum Ratings section. If this cannot be done, protection circuitry can be added in front of the AD8229 to limit the current into the inputs to a maximum current,  $I_{MAX}$ .

#### Input Voltages Beyond the Rails

If voltages beyond the rails are expected, use an external resistor in series with each input to limit current during overload conditions. The limiting resistor at the input can be computed from

$$R_{PROTECT} \ge \frac{|V_{IN} - V_{SUPPLY}|}{I_{MAX}}$$

Noise-sensitive applications may require a lower protection resistance. Low leakage diode clamps, such as the BAV199, can be used at the inputs to shunt current away from the AD8229 inputs and therefore allow smaller protection resistor values. To ensure current flows primarily through the external protection diodes, place a small value resistor, such as a 33  $\Omega,$  between the diodes and the AD8229.

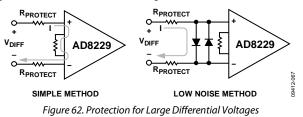


#### Large Differential Input Voltage at High Gain

If large differential voltages at high gain are expected, use an external resistor in series with each input to limit current during overload conditions. The limiting resistor at each input can be computed from

$$R_{PROTECT} \ge \frac{1}{2} \left( \frac{|V_{DIFF}| - 1V}{I_{MAX}} - R_G \right)$$

Noise-sensitive applications may require a lower protection resistance. Low leakage diode clamps, such as the BAV199, can be used across the inputs to shunt current away from the AD8229 inputs and therefore allow smaller protection resistor values.



#### I<sub>MAX</sub>

The maximum current into the AD8229 inputs, I<sub>MAX</sub>, depends on both time and temperature. At room temperature, the part can withstand a current of 10 mA for at least a day. This time is cumulative over the life of the part. At 210°C, limit current to 2 mA for the same period. The part can withstand 5 mA at 210°C for an hour, cumulative over the life of the part.

# **RADIO FREQUENCY INTERFERENCE (RFI)**

RF rectification is often a problem when amplifiers are used in applications that have strong RF signals. The disturbance can appear as a small dc offset voltage. High frequency signals can be filtered with a low-pass RC network placed at the input of the instrumentation amplifier, as shown in Figure 63. The filter limits the input signal bandwidth, according to the following relationship:

$$FilterFrequency_{DIFF} = \frac{1}{2\pi R(2C_D + C_C)}$$
$$FilterFrequency_{CM} = \frac{1}{2\pi RC_C}$$

where  $C_D \ge 10 C_C$ .

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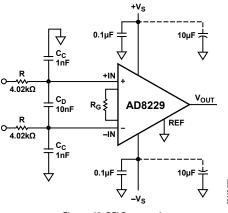


Figure 63. RFI Suppression

 $C_D$  affects the difference signal, and  $C_C$  affects the common-mode signal. Values of R and  $C_C$  should be chosen to minimize RFI. A mismatch between  $R \times C_C$  at the positive input and  $R \times C_C$  at the negative input degrades the CMRR of the AD8229. By using a value of  $C_D$  one magnitude larger than  $C_C$ , the effect of the mismatch is reduced, and performance is improved.

Resistors add noise; therefore, the resistor and capacitor values chosen depend on the desired tradeoff between noise, input impedance at high frequencies, and RFI immunity. The resistors used for the RFI filter can be the same as those used for input protection.

# CALCULATING THE NOISE OF THE INPUT STAGE

The total noise of the amplifier front end depends on much more than the 1 nV/ $\sqrt{\text{Hz}}$  headline specification of this data sheet. There are three main contributors: the source resistance, the voltage noise of the instrumentation amplifier, and the current noise of the instrumentation amplifier.

In the following calculations, noise is referred to the input (RTI). In other words, everything is calculated as if it appeared at the amplifier input. To calculate the noise referred to the amplifier output (RTO), simply multiple the RTI noise by the gain of the instrumentation amplifier.

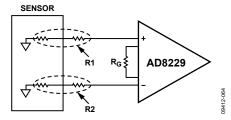


Figure 64. AD8229 with Source Resistance from Sensor and Protection Resistors

#### Source Resistance Noise

Any sensor connected to the AD8229 has some output resistance. There may also be resistance placed in series with inputs for protection from either overvoltage or radio frequency interference. This combined resistance is labeled R1 and R2 in Figure 64. Any resistor, no matter how well made, has a minimum level of noise. This noise is proportional to the square root of the resistor value. At room temperature, the value is approximately equal to 4 nV/ $\sqrt{Hz} \times \sqrt{(resistor value in k\Omega)}$ .

For example, assuming that the combined sensor and protection resistance on the positive input is  $4 \text{ k}\Omega$ , and on the negative input is  $1 \text{ k}\Omega$ , the total noise from the input resistance is

$$\sqrt{(4 \times \sqrt{4})^2 + (4 \times \sqrt{1})^2} = \sqrt{64 + 16} = 8.9 \text{ nV}/\sqrt{Hz}$$

#### Voltage Noise of the Instrumentation Amplifier

The voltage noise of the instrumentation amplifier is calculated using three parameters: the part input noise, output noise, and the R<sup>G</sup> resistor noise. It is calculated as follows:

Total Voltage Noise =

$$\sqrt{(Output Noise/G)^2 + (Input Noise)^2 + (Noise of R_G Resistor)^2}$$

For example, for a gain of 100, the gain resistor is 60.4  $\Omega$ . Therefore, the voltage noise of the in-amp is

$$\sqrt{(45/100)^2 + 1^2 + (4 \times \sqrt{0.0604})^2} = 1.5 \text{ nV}/\sqrt{\text{Hz}}$$

# **Current Noise of the Instrumentation Amplifier**

Current noise is calculated by multiplying the source resistance by the current noise.

For example, if the R1 source resistance in Figure 64 is 4 k $\Omega$ , and the R2 source resistance is 1 k  $\Omega$ , the total effect from the current noise is calculated as follows:

$$\sqrt{((4 \times 1.5)^2 + (1 \times 1.5)^2)} = 6.2 \text{ nV}/\sqrt{\text{Hz}}$$

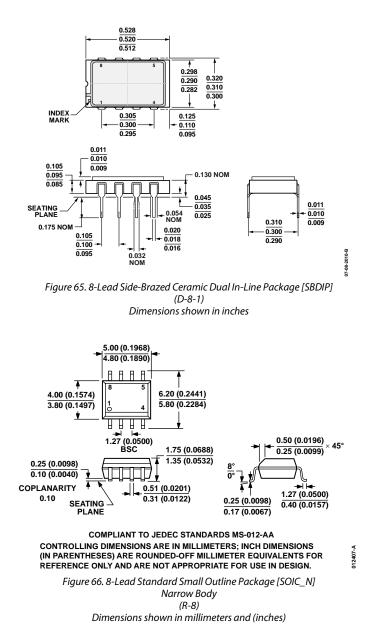
# **Total Noise Density Calculation**

To determine the total noise of the in-amp, referred to input, combine the source resistance noise, voltage noise, and current noise contribution by the sum of squares method.

For example, if the R1 source resistance in Figure 64 is 4 k $\Omega$ , the R2 source resistance is 1 k  $\Omega$ , and the gain of the in-amps is 100, the total noise, referred to input, is

$$\sqrt{8.9^2 + 1.5^2 + 6.2^2}$$
 = 11.0 nV/ $\sqrt{\text{Hz}}$ 

# **OUTLINE DIMENSIONS**



#### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Package Description	Package Option
AD8229HDZ	-40°C to +210°C	8-Lead Side-Brazed Ceramic Dual In-Line Package [SBDIP]	D-8-1
AD8229HRZ	–40°C to +175°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8
AD8229HRZ-R7	–40°C to +175°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8

<sup>1</sup> Z = RoHS Compliant Part.

# NOTES

# NOTES

# NOTES

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